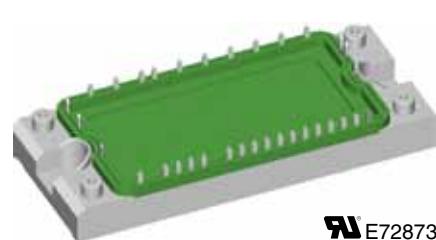
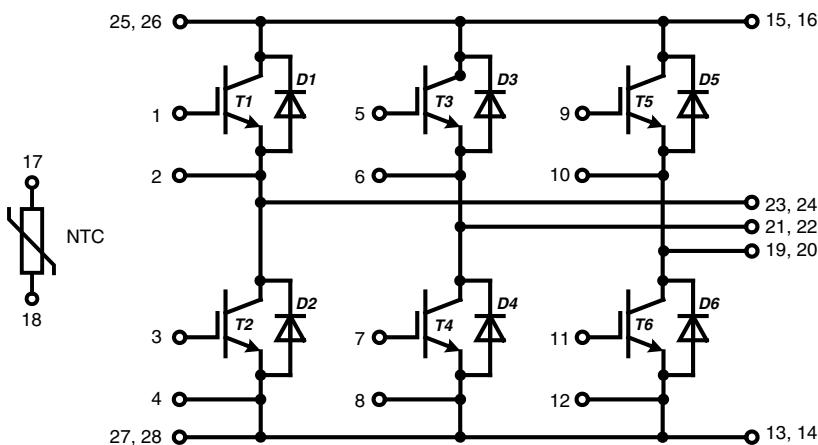


Six-Pack Trench IGBT

I_{C25} = 110 A
 V_{CES} = 1200 V
 $V_{CE(sat)}$ typ. = 1.7 V

Part name (Marking on product)

MWI 75-12T7T



E72873

Pin configuration see outlines.

Features:

- Trench IGBT technology
- low saturation voltage
- low switching losses
- square RBSOA, no latch up
- high short circuit capability
- positive temperature coefficient for easy parallelling
- MOS input, voltage controlled
- ultra fast free wheeling diodes
- solderable pins for PCB mounting
- package with copper base plate

Application:

- AC motor drives
- Solar inverter
- Medical equipment
- Uninterruptible power supply
- Air-conditioning systems
- Welding equipment
- Switched-mode and resonant-mode power supplies

Package:

- "E2-Pack" standard outline
- Insulated copper base plate
- Soldering pins for PCB mounting
- Temperature sense included

Output Inverter T1 - T6

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{CES}	collector emitter voltage	$T_{VJ} = 25^\circ C$		1200		V
V_{GES}	max. DC gate voltage	continuous		± 20		V
V_{GEM}	max. transient collector gate voltage	transient		± 30		V
I_{C25}	collector current	$T_C = 25^\circ C$	110			A
I_{C80}		$T_C = 80^\circ C$	75			A
I_{CM}	max. pulsed collector current	$t_p = 1 \text{ ms}$	$T_C = 80^\circ C$	150		A
P_{tot}	total power dissipation	$T_C = 25^\circ C$	355			W
$V_{CE(sat)}$	collector emitter saturation voltage	$I_C = 75 \text{ A}; V_{GE} = 15 \text{ V}$ on chip level	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.7 2.0	2.15	V
$V_{GE(th)}$	gate emitter threshold voltage	$I_C = 3 \text{ mA}; V_{GE} = V_{CE}$	$T_{VJ} = 25^\circ C$	5	5.8	6.5
I_{CES}	collector emitter leakage current	$V_{CE} = V_{CES}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	tbd	4	mA mA
I_{GES}	gate emitter leakage current	$V_{GE} = \pm 20 \text{ V}$		400		nA
C_{ies}	input capacitance	$V_{CE} = 25 \text{ V}; V_{GE} = 0 \text{ V}; f = 1 \text{ MHz}$	5350			pF
$Q_{G(on)}$	total gate charge	$V_{CE} = 600 \text{ V}; V_{GE} = \pm 15 \text{ V}; I_C = 75 \text{ A}$	700			nC
$t_{d(on)}$	turn-on delay time	$T_{VJ} = 125^\circ C$ $V_{CE} = 600 \text{ V}; I_C = 75 \text{ A}$ $V_{GE} = \pm 15 \text{ V}; R_G = 4.7 \Omega$	290			ns
t_r	current rise time		50			ns
$t_{d(off)}$	turn-off delay time		520			ns
t_f	current fall time		90			ns
E_{on}	turn-on energy per pulse		7			mJ
E_{off}	turn-off energy per pulse		9.5			mJ
RBSOA	reverse bias safe operating area	$V_{GE} = \pm 15 \text{ V}; R_G = 4.7 \Omega$	$T_{VJ} = 125^\circ C$ $V_{CEK} = 1150 \text{ V}$		100	A
SCSOA	short circuit safe operating area					
t_{sc}	short circuit duration	$V_{CE} = 900 \text{ V}; V_{GE} = \pm 15 \text{ V};$	$T_{VJ} = 125^\circ C$	300	10	μs
I_{sc}	short circuit current	$R_G = 4.7 \Omega; \text{non-repetitive}$			A	
R_{thJC}	thermal resistance junction to case	(per IGBT)			0.35	K/W

Output Inverter D1 - D6

Ratings

Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_{RRM}	max. repetitive reverse voltage	$T_{VJ} = 25^\circ C$		1200		V
I_{F25}	forward current	$T_C = 25^\circ C$		135		A
I_{F80}		$T_C = 80^\circ C$		90		A
V_F	forward voltage	$I_F = 100 \text{ A}; V_{GE} = 0 \text{ V}$	$T_{VJ} = 25^\circ C$ $T_{VJ} = 125^\circ C$	1.95 1.95	2.2	V V
Q_{rr}	reverse recovery charge	$T_{VJ} = 125^\circ C$ $V_R = 600 \text{ V}$ $di_F/dt = -1600 \text{ A}/\mu\text{s}$ $I_F = 100 \text{ A}; V_{GE} = 0 \text{ V}$	12.5			μC
I_{RM}	max. reverse recovery current		100			A
t_{rr}	reverse recovery time		350			ns
E_{rec}	reverse recovery energy		4			mJ
R_{thJC}	thermal resistance junction to case	(per diode)			0.4	K/W

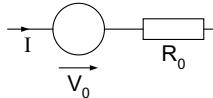
Temperature Sensor NTC

Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
R_{25}	<i>resistance</i>		$T_c = 25^\circ\text{C}$	4.75	5.0	$\text{k}\Omega$
$B_{25/50}$				3375	5.25	K

Module

Ratings						
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
T_{vj}	<i>operating temperature</i>		-40		125	$^\circ\text{C}$
T_{vjm}	<i>max. virtual junction temperature</i>				150	$^\circ\text{C}$
T_{stg}	<i>storage temperature</i>		-40		125	$^\circ\text{C}$
V_{ISOL}	<i>isolation voltage</i>	$I_{ISOL} \leq 1 \text{ mA}; 50/60 \text{ Hz}$			2500	V~
CTI	<i>comparative tracking index</i>				200	
M_d	<i>mounting torque (M5)</i>		2.7		3.3	Nm
d_s	<i>creep distance on surface</i>		6			mm
d_A	<i>strike distance through air</i>		6			mm
$R_{pin-chip}$	<i>resistance pin to chip</i>			2.5		$\text{m}\Omega$
R_{thCH}	<i>thermal resistance case to heatsink</i>	with heatsink compound		0.02		K/W
Weight				180		g

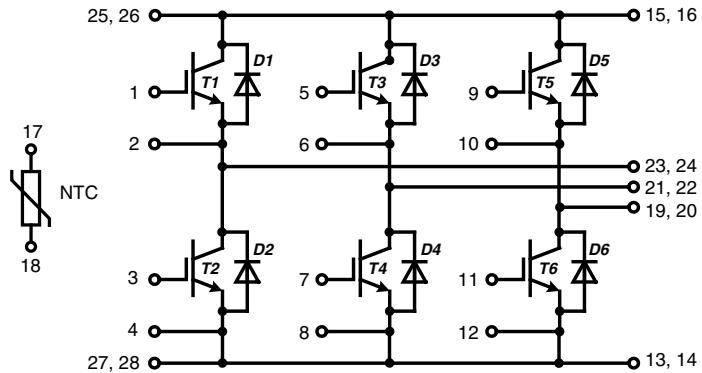
Equivalent Circuits for Simulation



Ratings

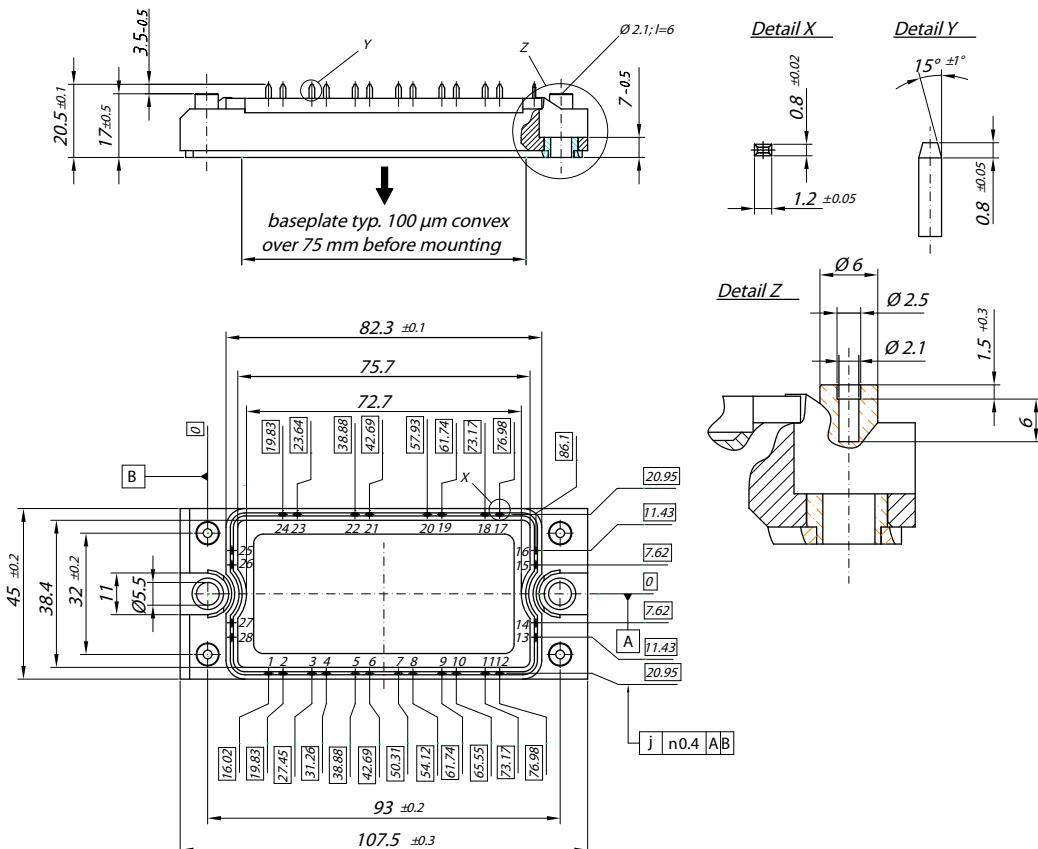
Symbol	Definitions	Conditions	min.	typ.	max.	Unit
V_0	<i>IGBT</i>	$T1 - T6$		$T_{vj} = 125^\circ\text{C}$	1.0	V
R_0				13.3		$\text{m}\Omega$
V_0	<i>Diode</i>	$D1 - D6$		$T_{vj} = 150^\circ\text{C}$	1.09	V
R_0				9.1		$\text{m}\Omega$

Circuit Diagram

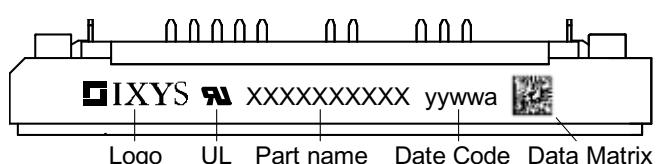


Outline Drawing

Dimensions in mm (1 mm = 0.0394")



Product Marking



Ordering	Part Name	Marking on Product	Delivering Mode	Base Qty	Ordering Code
Standard	MWI 75-12T7T	MWI75-12T7T	Box	6	501979

IXYS reserves the right to change limits, test conditions and dimensions.

20100910e

Inverter T1 - T6

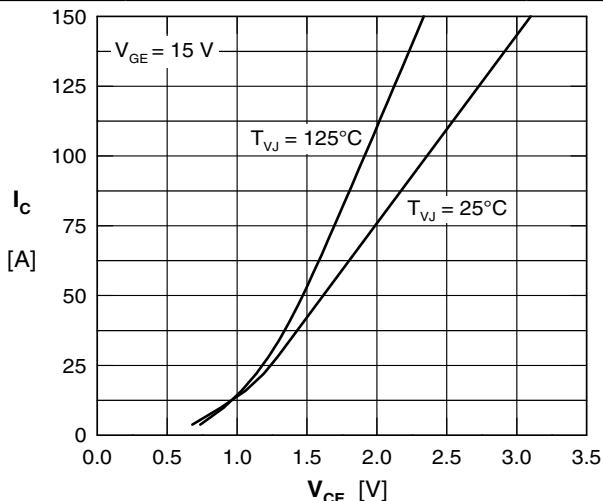


Fig. 1 Typ. output characteristic

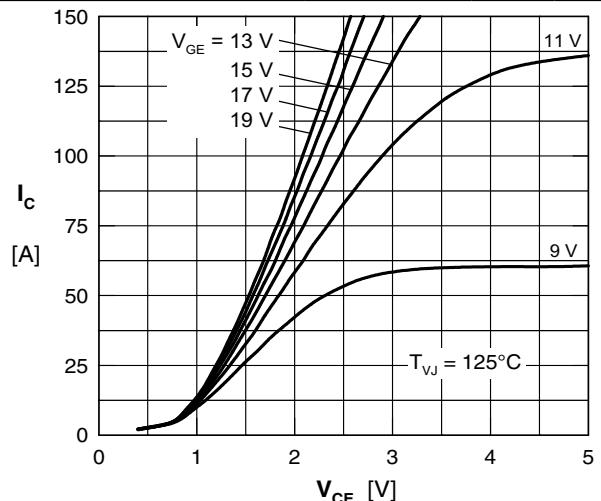


Fig. 2 Typ. output characteristic

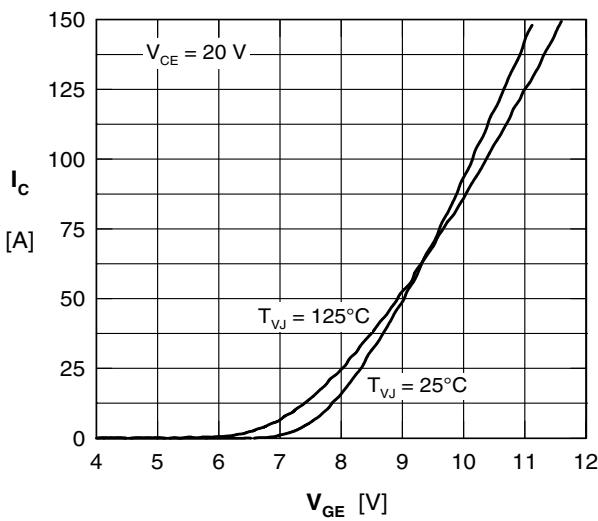


Fig. 3 Typ. transfer characteristic

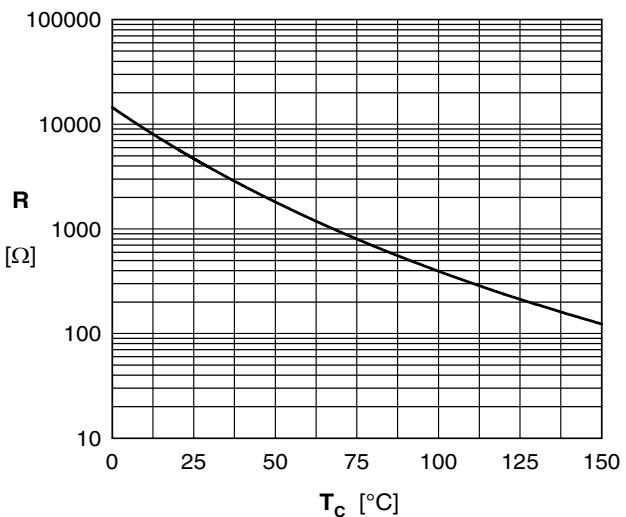


Fig. 4 Typ. NTC resistance versus temperature

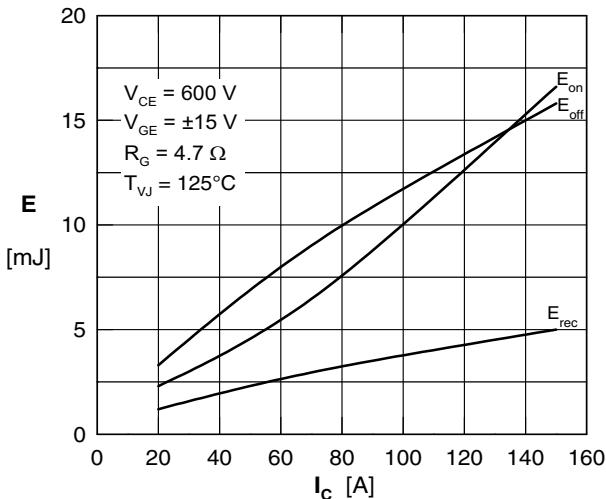


Fig. 5 Typ. switching losses versus collector current impedance

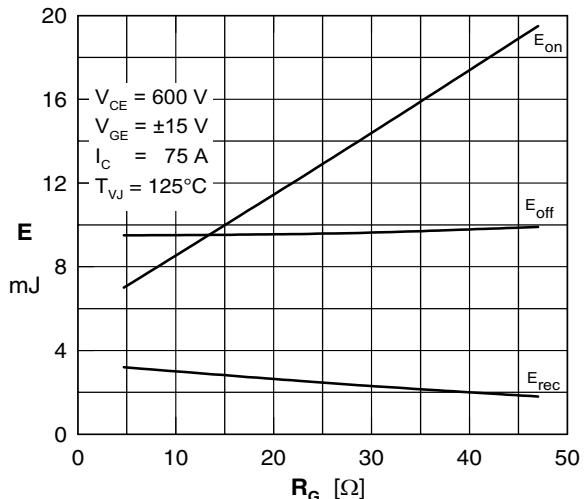


Fig. 6 Typ. switching losses vs. gate resistance

Inverter D1 - D6

